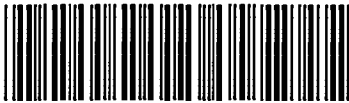


Search Notes

Application/Control No.

09/093,271

Examiner

Son P. Huynh

Applicant(s)/Patent under
Reexamination

FUJII, TOSHIYA

Art Unit

2611

SEARCHED

| Class | Subclass | Date | Examiner |
|--------|----------|-----------|----------|
| UPDATE | SEARCH | 5/24/2005 | AH |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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| 725 | 109-110 | 5/24/2005 | AH |
| 725 | 112-113 | 5/24/2005 | AH |
| 345 | 715,723 | 5/24/2005 | AH |
| 715/719,784,785,500.1; 709/217-219; 725/39-61 | | 5/24/2005 | AH |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST TEXT SEARCH ENCLOSED | 5/24/2005 | AH |
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